

<b>Notice of References Cited</b>	Application/Control No. 10/726,477	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Amanda C. Walke	Art Unit 1752	Page 1 of 1

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	C	US-6,472,128	10-2002	Thackeray et al.	430/322
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**NON-PATENT DOCUMENTS**

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